

**Search Notes**

Application/Control No.

10/790,142

Examiner

Shun Lee

Applicant(s)/Patent under  
Reexamination

SENDAI ET AL.

Art Unit

2884

**SEARCHED**

Class	Subclass	Date	Examiner
250	252.1	3/15/2006	SL
378	207	3/15/2006	SL
Above	UPDATED	9/19/2006	SL

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (US-PGPUB, USPAT, USOCR, EPO, JPO, IBM_TDB) - See Search History Printout	9/19/2006	SL